Application/Control No. 10/042,846 Notice of References Cited Application/Control No. 10/042,846 Examiner Tse Chen Applicant(s)/Patent Under Reexamination HAIMOVSKY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,948,101	09-1999	David et al.	713/2
	В	US-			
	C.	US-			
	D	US-			
	Ш	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J.	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

NON-FATERI DOCUMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	V						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.